

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SAISHO ET AL.	
		Examiner John J. Zimmerman	Art Unit 1775	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,991,647	02-1991	Kawabe et al.	165/134.1
*	B	US-5,302,342 A	04-1994	Kawabe et al.	420/546
*	C	US-6,302,973 B1	10-2001	Haszler et al.	148/437
*	D	US-6,921,584 B2	07-2005	Syslak et al.	428/654
*	E	US-2002/0037426	03-2002	Yamada et al.	428/654
*	F	US-2003/0086812 A1	05-2003	Wittebrood et al.	420/532
*	G	US-2004/0118492 A1	06-2004	Stenqvist, Torkel	148/692
*	H	US-2006/0141282 A1	06-2006	Ueda et al.	428/650
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/090031 A1	11-2002	PCT	Syslak et al.	---
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.